

Absolute Maximum Rating^[1] T_A=25°C

Symbol	Parameter	Units	Absolute Max.
V _{dd,max}	Device Voltage, RF output to ground	V	5.5
P _{in,max}	CW RF Input Power	dBm	20
P _{diss}	Total Power Dissipation ^[3]	W	0.47
T _{j,MAX}	Junction Temperature	°C	150
T _{STG}	Storage Temperature	°C	-65 to 150

Thermal Resistance

Thermal Resistance ^[2] θ_{JC} = 76°C/W
(V_{dd} = 5 V, I_{ds} = 57.5 mA, T_c = 85°C)

Notes:

1. Operation of this device in excess of any of these limits may cause permanent damage.
2. Thermal resistance measured using Infrared measurement technique.
3. This is limited by maximum V_{dd} and I_{ds}. Derate 13.2 mW/°C for T_c > 114°C.

Product Consistency Distribution Charts^[1, 2]

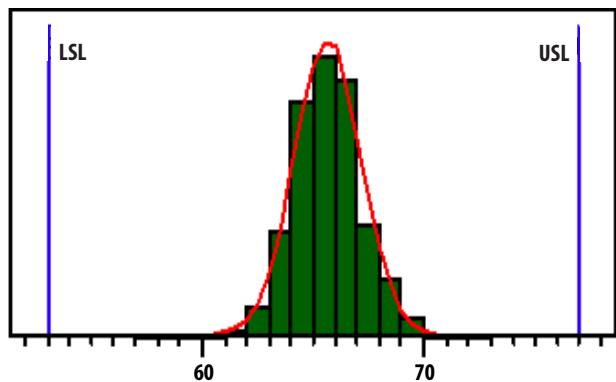


Figure 1. I_{ds}, LSL=53mA , nominal=65mA, USL=77mA

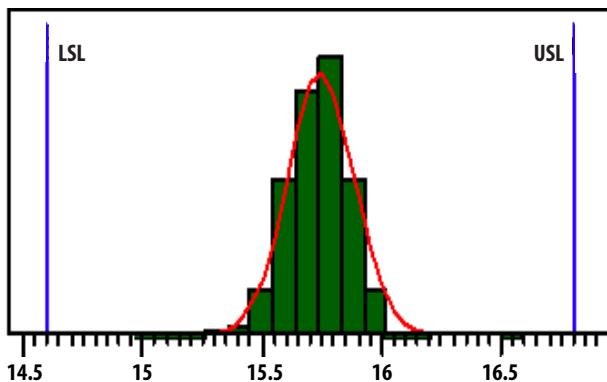


Figure 2. Gain, LSL=14.6dB, nominal=15.7dB, USL=16.8dB

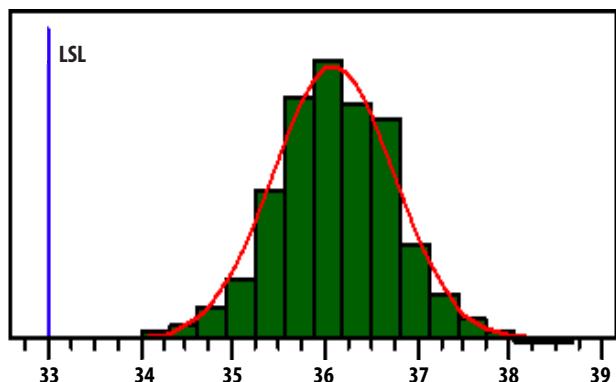


Figure 3. OIP3, LSL=33dBm, nominal=36dBm

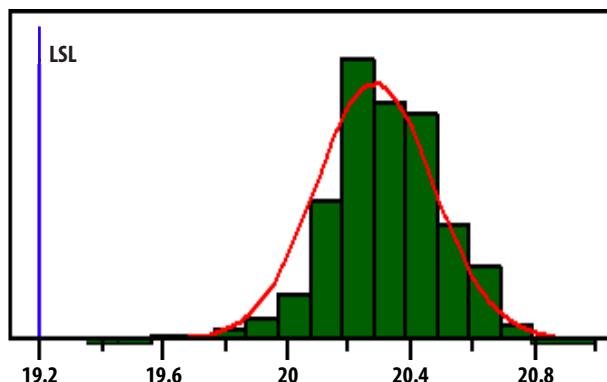


Figure 4. P1dB, LSL=19.2dBm, nominal=20.3dBm

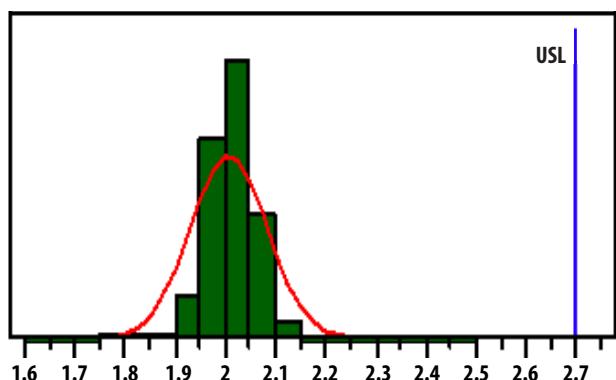


Figure 5. NF, nominal=2dB, USL=2.7dB

Notes:

1. Distribution data sample size is 3000 samples taken from 3 different wafer lots. Future wafers allocated to this product may have nominal values anywhere between the upper and lower limits.
2. Measurements were made on a characterization test board, which represents a trade-off between optimal OIP3, gain and P1dB. Circuit trace losses have not been de-embedded from measurements above.

Electrical Specifications [1]

$T_A = 25^\circ\text{C}$, $V_{dd} = 5\text{V}$

Symbol	Parameter and Test Condition	Frequency	Units	Min.	Typ.	Max.
I_{ds}	Quiescent current	N/A	mA	53	65	77
Gain	Gain	40MHz	dB		15.9	
		900MHz			15.5	
		1950MHz		14.6	15.7	16.8
OIP3 [2]	Output Third Order Intercept Point	40MHz	dBm		37	
		900MHz			38	
		1950MHz		33	36	-
NF	Noise Figure	40MHz	dB		2.0	
		900MHz			1.9	
		1950MHz		-	2.0	2.7
S11	Input Return Loss, 50Ω source	40MHz	dB		-16	
		900MHz			-17	
		1950MHz			-13	
S22	Output Return Loss, 50Ω load	40MHz	dB		-16	
		900MHz			-16.5	
		1950MHz			-13	
S12	Reverse Isolation	40MHz	dB		-17	
		900MHz			-17	
		1950MHz			-22	
OP1dB	Output Power at 1dB Gain Compression	40MHz	dBm		21	
		900MHz			20	
		1950MHz		19.2	20	-

Notes:

1. Measurements obtained using demo board described in Figure 30 and 31. 40MHz data was taken with 40MHz - 2GHz Application Test Circuit, 900MHz data with 0.2GHz – 2.6GHz Application Test Circuit and 1.95GHz data with 1.5GHz - 2.6GHz Application Test Circuit respectively.
2. OIP3 test condition: $F_{RF1} - F_{RF2} = 10\text{MHz}$ with input power of -15dBm per tone measured at worse side band.
3. Use proper bias, heat sink and de-rating to ensure maximum channel temperature is not exceeded. See absolute maximum ratings and application note (if applicable) for more details.

Typical Performance (40MHz - 2GHz)

$T_A = 25^\circ\text{C}$, $V_{dd} = 5\text{V}$, Input Signal=CW. Application Test Circuit is shown in Figure 30 and Table 1.

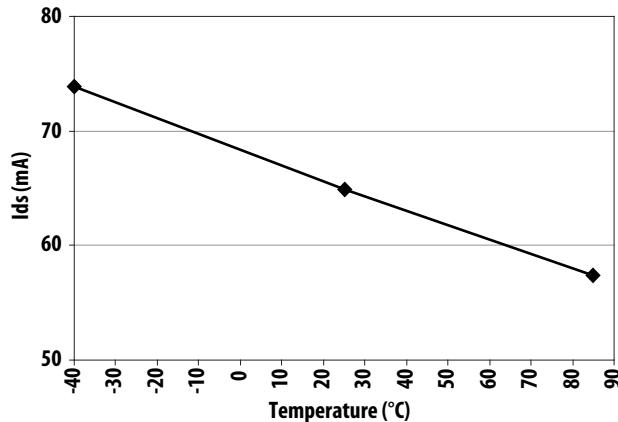


Figure 6. Id_s over Temperature

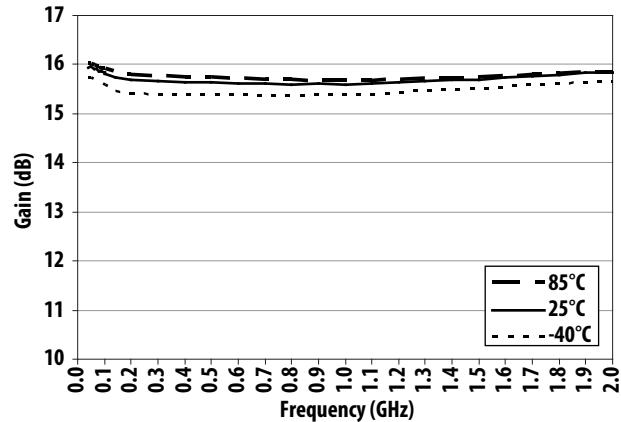


Figure 7. Gain over Frequency and Temperature

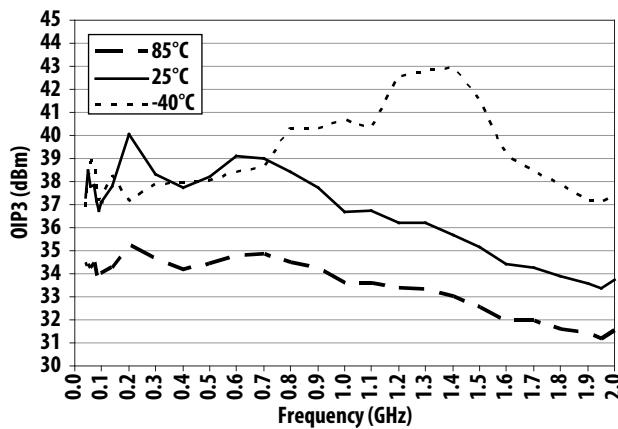


Figure 8. OIP3 over Frequency and Temperature

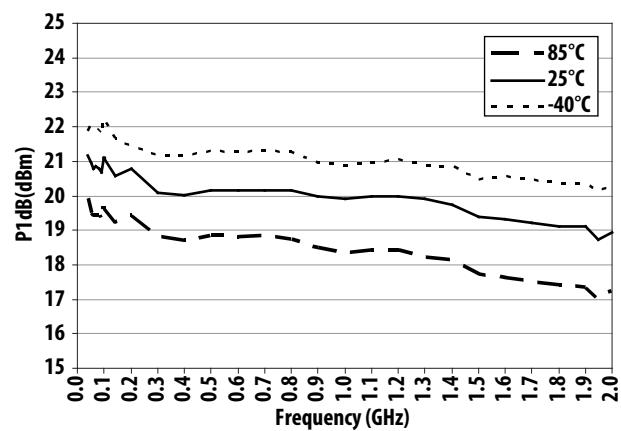


Figure 9. P1dB over Frequency and Temperature

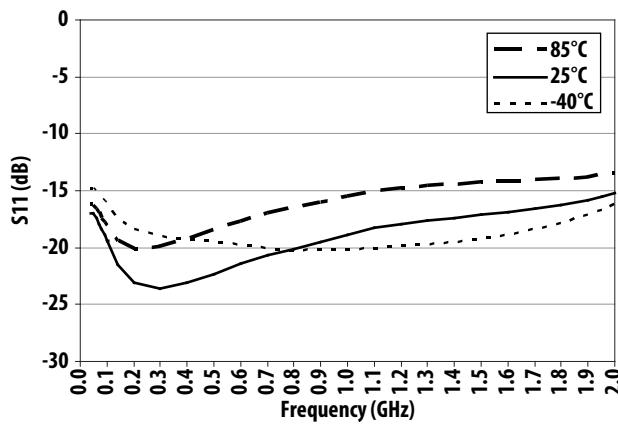


Figure 10. S_{11} over Frequency and Temperature

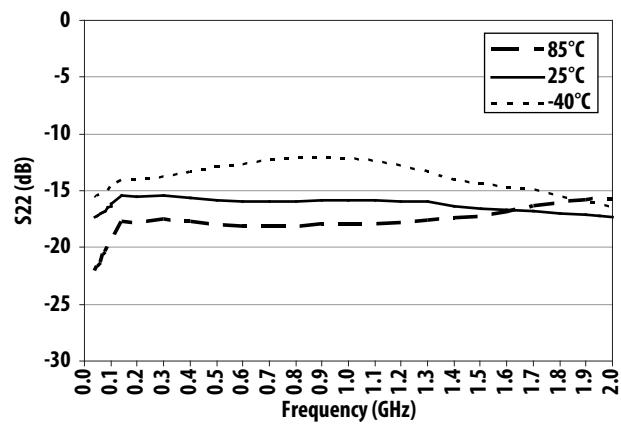


Figure 11. S_{22} over Frequency and Temperature

Typical Performance (40MHz - 2GHz)

$T_A = 25^\circ\text{C}$, $V_{dd} = 5\text{V}$, Input Signal=CW. Application Test Circuit is shown in Figure 30 and Table 1.

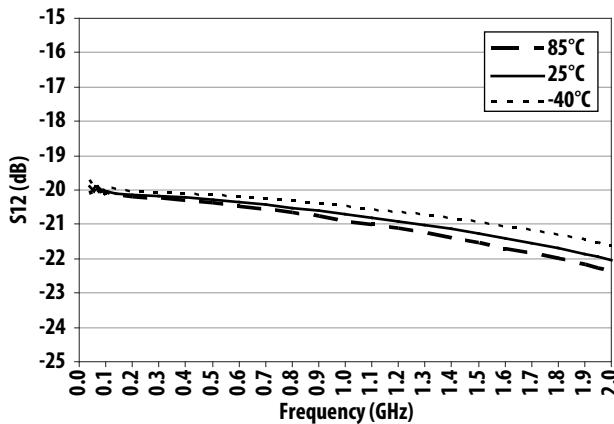


Figure 12. S12 over Frequency and Temperature

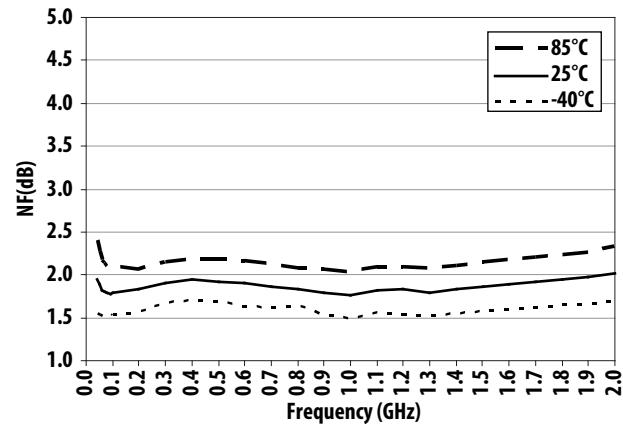


Figure 13. Noise Figure over Frequency and Temperature

Typical Performance (0.2GHz - 2.6GHz)

$T_A = 25^\circ\text{C}$, $V_{dd} = 5\text{V}$, Input Signal=CW. Application Test Circuit is shown in Figure 30 and Table 2.

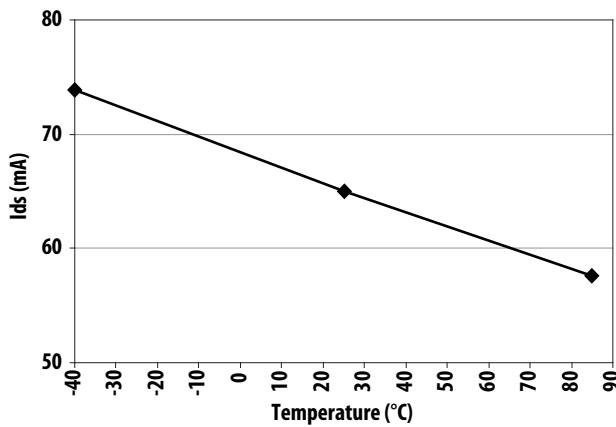


Figure 14. Ids over Temperature

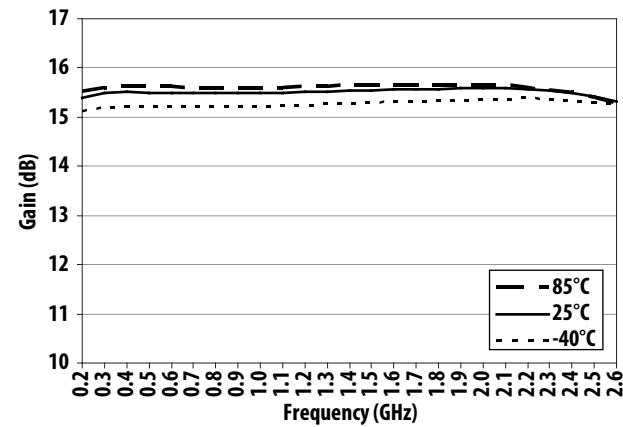


Figure 15. Gain over Frequency and Temperature

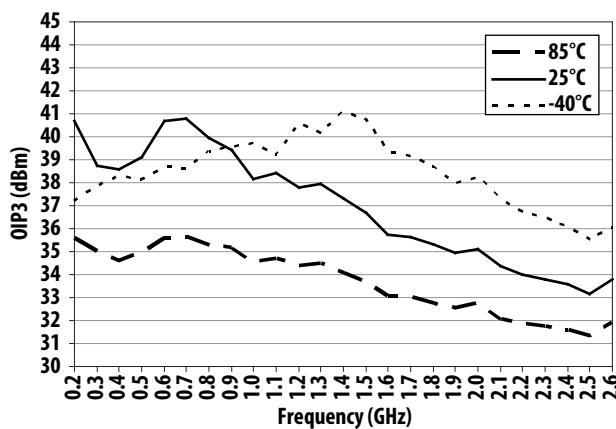


Figure 16. OIP3 over Frequency and Temperature

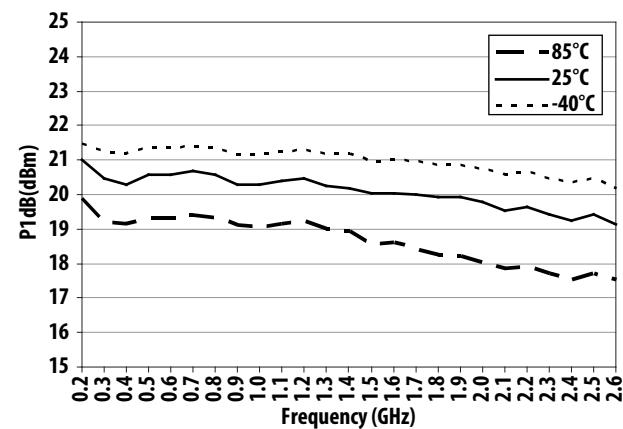


Figure 17. P1dB over Frequency and Temperature

Typical Performance (0.2GHz - 2.6GHz)

$T_A = 25^\circ\text{C}$, $V_{dd} = 5\text{V}$, Input Signal=CW. Application Test Circuit is shown in Figure 30 and Table 2.

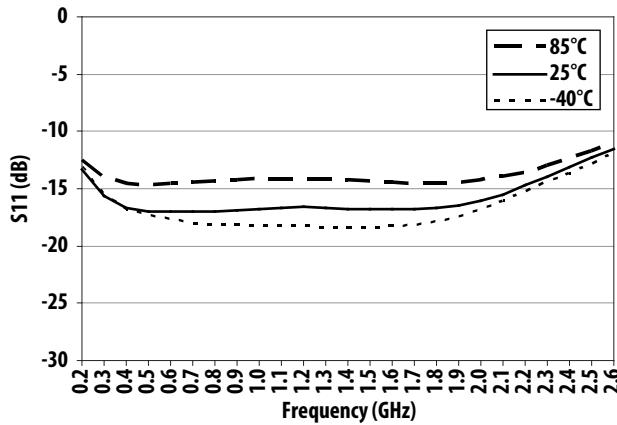


Figure 18. S11 over Frequency and Temperature

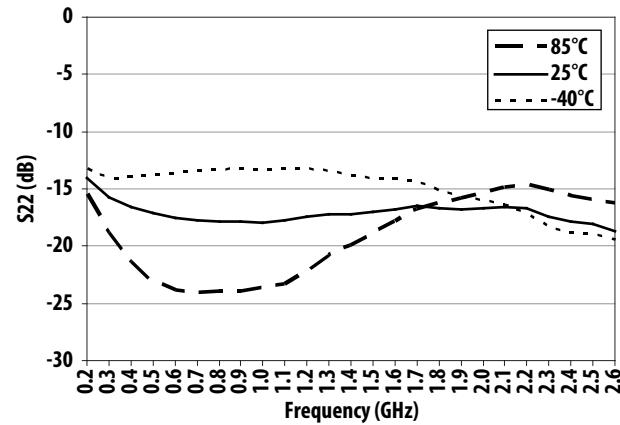


Figure 19. S22 over Frequency and Temperature

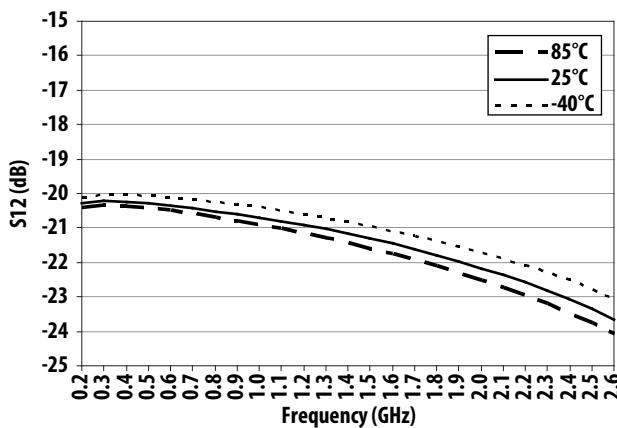


Figure 20. S12 over Frequency and Temperature

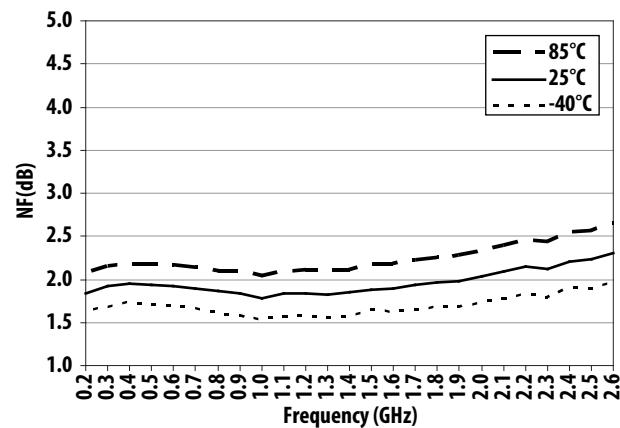


Figure 21. Noise Figure over Frequency and Temperature

Typical Performance (1.5GHz - 2.6GHz)

$T_A = 25^\circ\text{C}$, $V_{dd} = 5\text{V}$, Input Signal=CW. Application Test Circuit is shown in Figure 30 and Table 3.

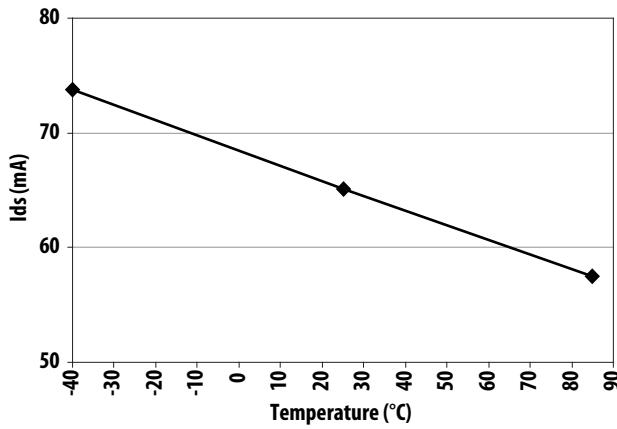


Figure 22. Ids over Temperature

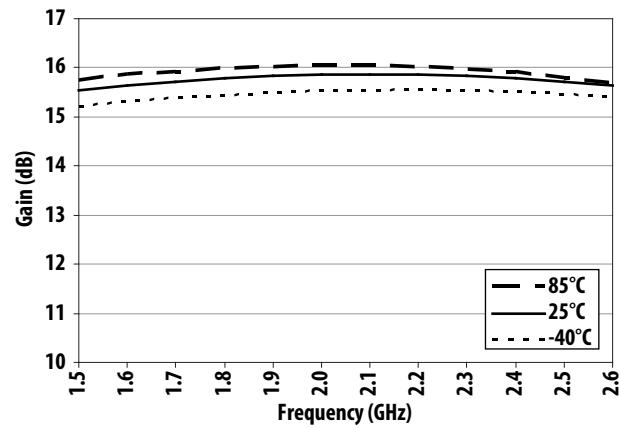


Figure 23. Gain over Frequency and Temperature

Typical Performance (1.5GHz - 2.6GHz)

$T_A = 25^\circ\text{C}$, $V_{dd} = 5\text{V}$, Input Signal=CW. Application Test Circuit is shown in Figure 30 and Table 3.

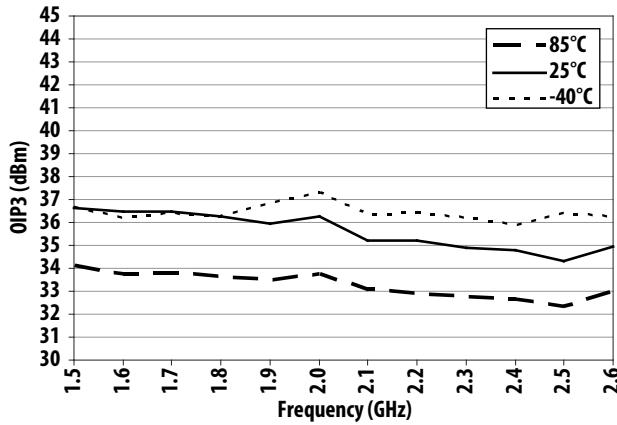


Figure 24. OIP3 over Frequency and Temperature

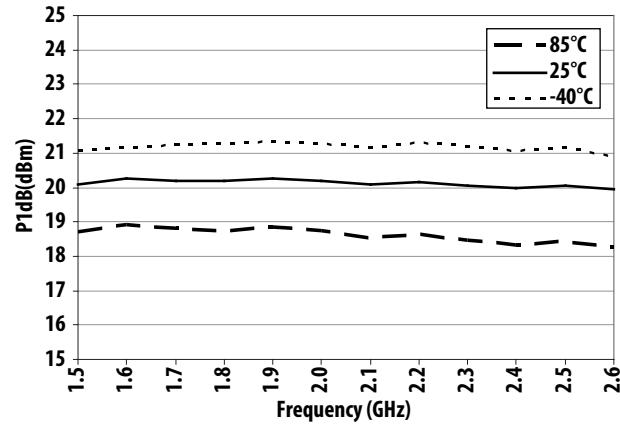


Figure 25. P1dB over Frequency and Temperature

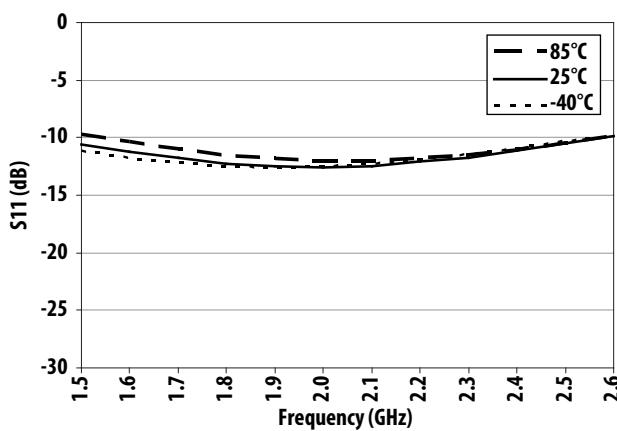


Figure 26. S11 over Frequency and Temperature

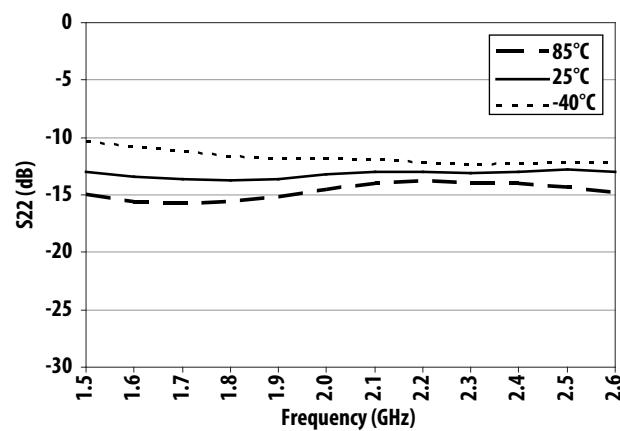


Figure 27. S22 over Frequency and Temperature

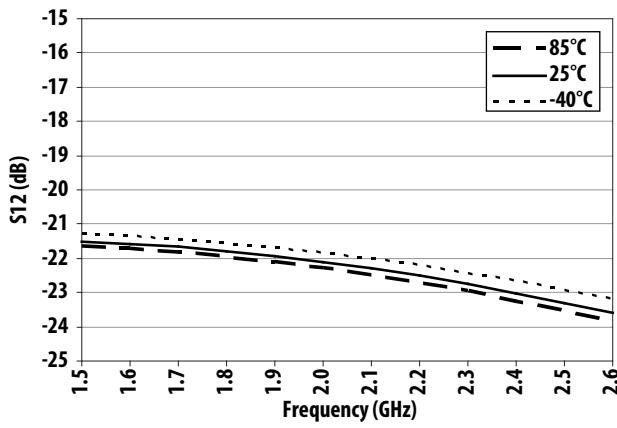


Figure 28. S12 over Frequency and Temperature

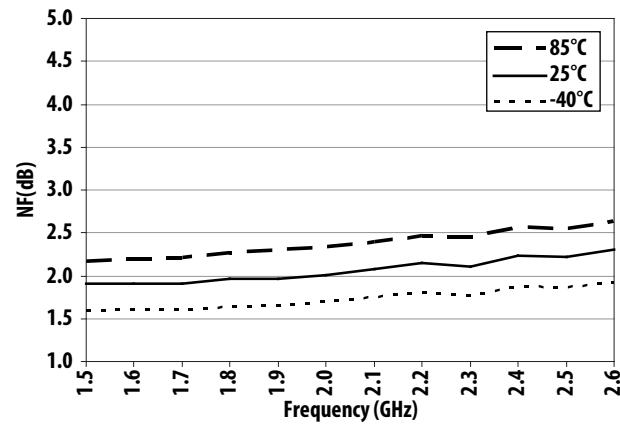


Figure 29. Noise Figure over Frequency and Temperature

Application Schematic Components Table and Demo Board

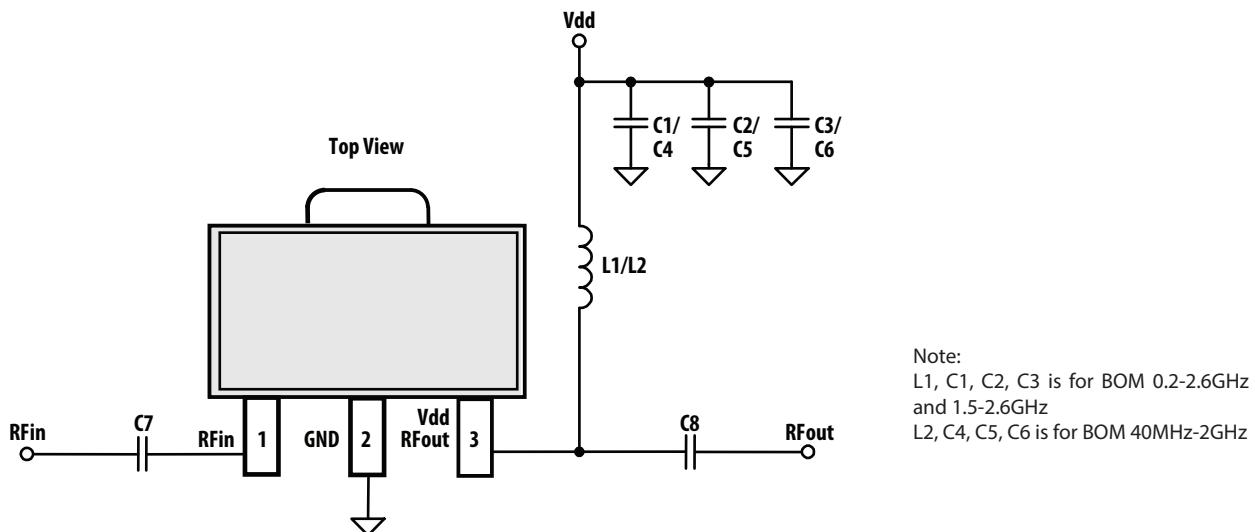


Figure 30. Application Schematic

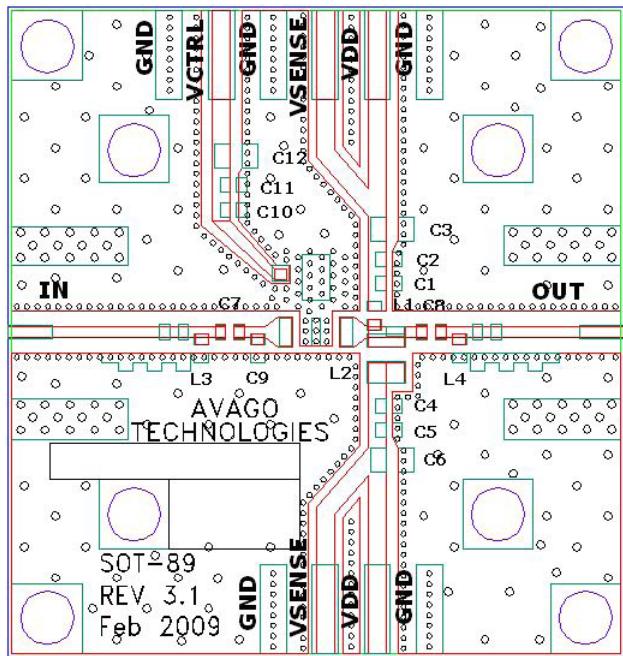


Figure 31. Demo board Layout

- Recommended PCB material is 10 mils Rogers RO4350, with FR4 backing for mechanical strength.
- Suggested component values may vary according to layout and PCB material.

Demo board Part List

Table 1. 40MHz - 2GHz Application Schematic Components

Circuit Symbol	Size	Value	Part Number	Description
L2	0805	820nH	LLQ2012-series (Toko)	Wire Wound Chip Inductor
C4	0402	100pF	GRM1555C1H101JZ01 (Murata)	Ceramic Chip Capacitor
C5	0402	0.1uF	GRM155R71C104KA88D (Murata)	Ceramic Chip Capacitor
C6	0805	2.2uF	GRM21BR61E225KA12L (Murata)	Ceramic Chip Capacitor
C7	0402	0.1uF	GRM155R71C104KA88D (Murata)	Ceramic Chip Capacitor
C8	0402	0.1uF	GRM155R71C104KA88D (Murata)	Ceramic Chip Capacitor

Table 2. 0.2GHz - 2.6GHz Application Schematic Components

Circuit Symbol	Size	Value	Part Number	Description
L1	0603	100nH	LLQ1608-FR10 (Toko)	Wire Wound Chip Inductor
C1	0402	10pF	GRM1555C1H100JZ01 (Murata)	Ceramic Chip Capacitor
C2	0402	0.1uF	GRM155R71C104KA88D (Murata)	Ceramic Chip Capacitor
C3	0805	2.2uF	GRM21BR61E225KA12L (Murata)	Ceramic Chip Capacitor
C7	0402	100pF	GRM1555C1H101JZ01 (Murata)	Ceramic Chip Capacitor
C8	0402	100pF	GRM1555C1H101JZ01 (Murata)	Ceramic Chip Capacitor

Table 3. 1.5GHz - 2.6GHz Application Schematic Components

Circuit Symbol	Size	Value	Part Number	Description
L1	0402	5.6nH	LL1005-FHL5N6 (Toko)	MLC Inductor
C1	0402	100pF	GRM1555C1H101JZ01 (Murata)	Ceramic Chip Capacitor
C2	0402	0.1uF	GRM155R71C104KA88D (Murata)	Ceramic Chip Capacitor
C3	0805	2.2uF	GRM21BR61E225KA12L (Murata)	Ceramic Chip Capacitor
C7	0402	20pF	GRM1555C1H200JZ01 (Murata)	Ceramic Chip Capacitor
C8	0402	20pF	GRM1555C1H200JZ01 (Murata)	Ceramic Chip Capacitor

Test Circuit for S-Parameter and Noise Parameter

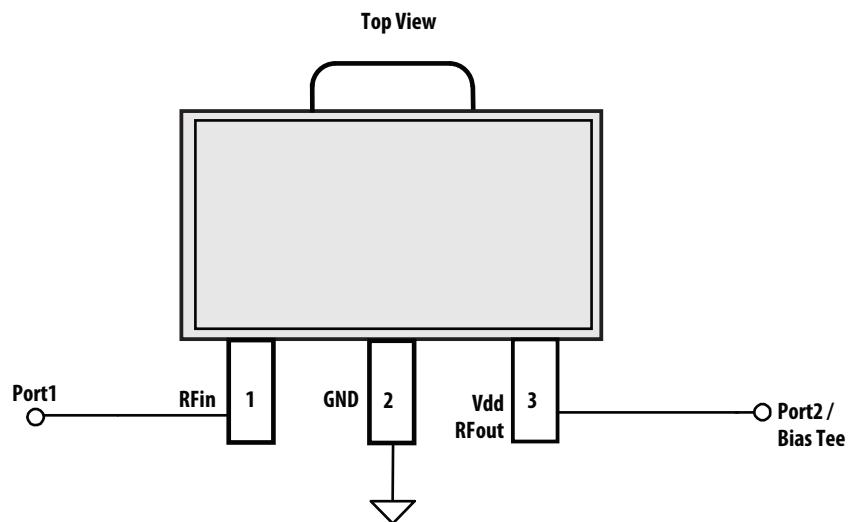


Figure 32. S-parameter and Noise parameter test circuit

Typical S-Parameter (Vdd = 5V, TA = 25°C, 50 ohm)

Freq (GHz)	S11 (dB)	S11 (ang)	S21 (dB)	S21 (ang)	S12 (dB)	S12 (ang)	S22 (dB)	S22 (ang)
0.04	-17.04	-88.23	16.16	167.09	-20.08	6.83	-14.55	-138.35
0.1	-23.82	-99.63	15.83	170.40	-20.02	-1.16	-15.92	-163.34
0.2	-27.02	-106.63	15.78	167.69	-20.03	-7.14	-16.38	-173.98
0.3	-26.83	-116.89	15.78	163.41	-20.05	-12.02	-16.45	-179.28
0.4	-24.42	-127.93	15.78	158.71	-20.08	-16.72	-16.24	176.99
0.5	-22.60	-130.33	15.79	153.85	-20.12	-21.30	-16.34	177.06
0.6	-21.35	-134.41	15.81	148.88	-20.16	-25.84	-16.37	178.09
0.7	-20.18	-140.06	15.83	143.85	-20.21	-30.36	-16.39	178.81
0.8	-19.10	-146.29	15.85	138.73	-20.27	-34.85	-16.40	178.64
0.9	-18.13	-152.78	15.88	133.58	-20.34	-39.29	-16.35	177.88
1	-17.42	-160.67	15.91	128.38	-20.42	-43.88	-16.16	177.12
1.1	-16.72	-166.54	15.96	123.11	-20.50	-48.37	-16.54	175.97
1.2	-16.21	-176.41	16.00	117.79	-20.60	-52.85	-16.29	174.49
1.3	-15.66	173.51	16.03	112.37	-20.70	-57.37	-16.03	172.05
1.4	-15.09	162.73	16.07	106.92	-20.82	-61.94	-15.76	168.90
1.5	-14.41	151.57	16.10	101.34	-20.96	-66.51	-15.42	164.84
1.6	-13.67	140.49	16.12	95.64	-21.12	-71.09	-15.11	160.22
1.7	-12.91	130.11	16.13	89.95	-21.29	-75.69	-14.81	155.66
1.8	-12.12	120.06	16.13	84.16	-21.47	-80.32	-14.56	150.71
1.9	-11.34	110.67	16.12	78.29	-21.68	-84.88	-14.33	145.47
2	-10.60	101.66	16.10	72.45	-21.90	-89.37	-14.14	140.05
2.1	-9.89	93.15	16.06	66.53	-22.14	-93.79	-13.96	134.67
2.2	-9.25	84.93	16.01	60.60	-22.41	-98.15	-13.84	129.50
2.3	-8.70	77.25	15.96	54.75	-22.69	-102.42	-13.80	124.63
2.4	-8.17	69.77	15.88	48.83	-22.98	-106.71	-13.80	119.72
2.5	-7.72	62.66	15.80	43.02	-23.28	-110.71	-13.84	115.08
2.6	-7.32	55.78	15.70	37.21	-23.59	-114.68	-13.93	110.60
2.7	-6.97	48.95	15.61	31.35	-23.93	-118.51	-14.07	106.56
2.8	-6.68	42.26	15.51	25.64	-24.25	-122.20	-14.28	102.99
2.9	-6.44	35.55	15.40	19.84	-24.57	-125.87	-14.56	99.69
3	-6.23	28.95	15.30	14.15	-24.89	-129.40	-14.95	96.77
4	-4.89	-49.49	13.83	-45.76	-28.13	-161.64	-23.03	97.19
5	-2.59	-116.16	10.78	-101.46	-31.11	175.49	-25.89	-152.28
6	-2.03	-163.08	8.27	-146.84	-31.55	155.55	-32.05	-167.12
7	-2.13	126.91	6.05	159.94	-30.84	116.80	-20.70	67.94
8	-1.18	63.71	1.85	107.76	-32.11	72.53	-15.41	31.66
9	-0.90	21.52	-2.15	65.10	-33.21	35.83	-13.70	-6.02
10	-0.96	-35.93	-6.31	19.48	-34.36	-2.85	-11.83	-41.95
11	-0.57	-88.75	-11.99	-20.95	-37.07	-31.83	-8.45	-71.80
12	-0.28	-111.33	-17.53	-45.68	-39.48	-41.74	-5.84	-86.38
13	-0.35	-128.02	-21.20	-67.24	-39.17	-49.14	-4.59	-102.14
14	-0.51	-151.74	-23.85	-91.12	-37.88	-64.15	-4.29	-122.42
15	-0.41	-179.96	-26.91	-116.90	-37.36	-88.21	-3.95	-151.92
16	-0.27	166.93	-30.45	-133.25	-39.05	-106.29	-3.02	-168.71
17	-0.33	157.77	-33.85	-145.37	-42.49	-109.41	-2.77	179.33
18	-0.37	144.27	-37.31	-155.13	-44.53	-97.93	-2.54	169.25
19	-0.58	124.17	-41.44	-156.44	-42.48	-80.86	-3.33	156.65
20	-0.56	103.21	-49.19	-130.39	-40.96	-75.27	-3.99	129.84

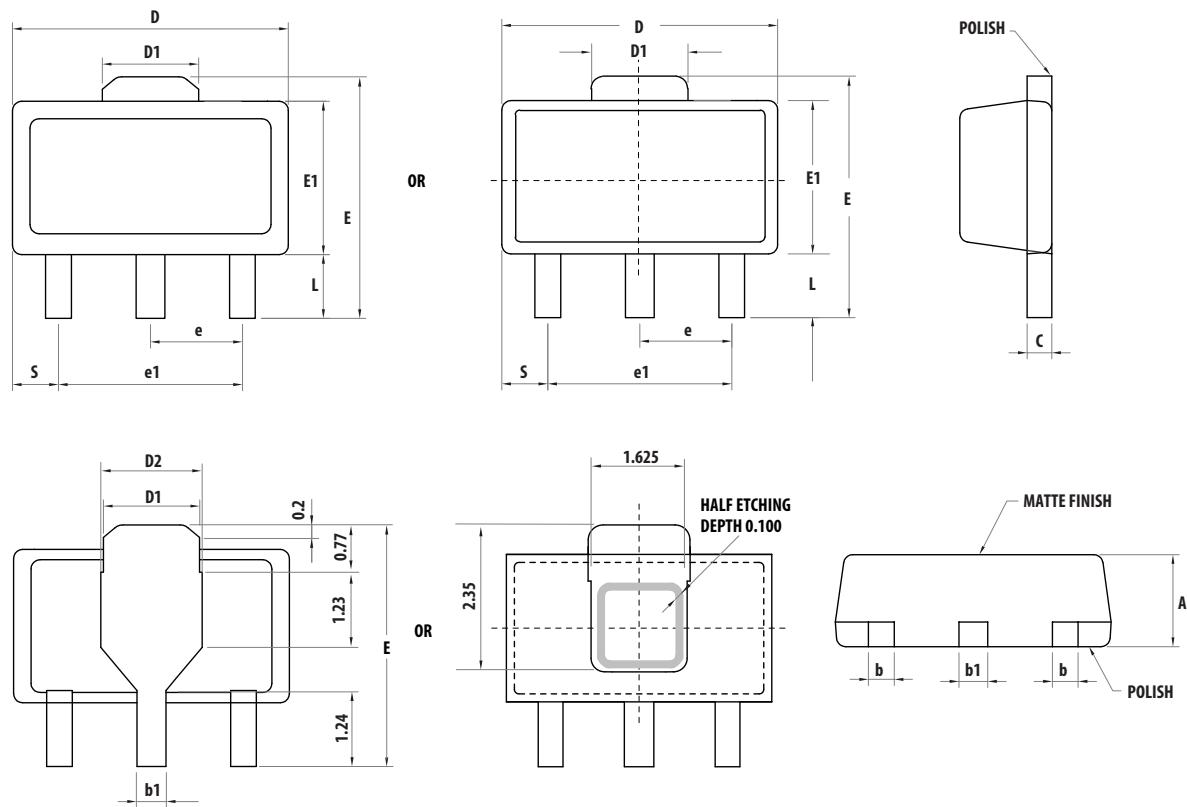
Typical Noise Parameters (Vdd = 5V, TA = 25°C, 50 ohm)

Freq (GHz)	F _{min} (dB)	Γ _{opt Mag}	Γ _{opt Ang}	R _n /Z ₀
0.4	1.80	0.036	-102	0.19
0.9	1.70	0.051	-86	0.19
1.0	1.75	0.071	-76	0.20
1.7	1.90	0.11	-52	0.25
1.95	1.93	0.17	-46	0.28
2.0	1.90	0.16	-41	0.29
2.5	1.81	0.24	-19	0.38
3.0	1.85	0.30	3.7	0.49
3.5	1.81	0.40	27	0.55
4.0	2.24	0.45	58	0.54
4.5	2.71	0.47	89	0.50
5.0	3.39	0.55	121	0.43

Part Number Ordering Information

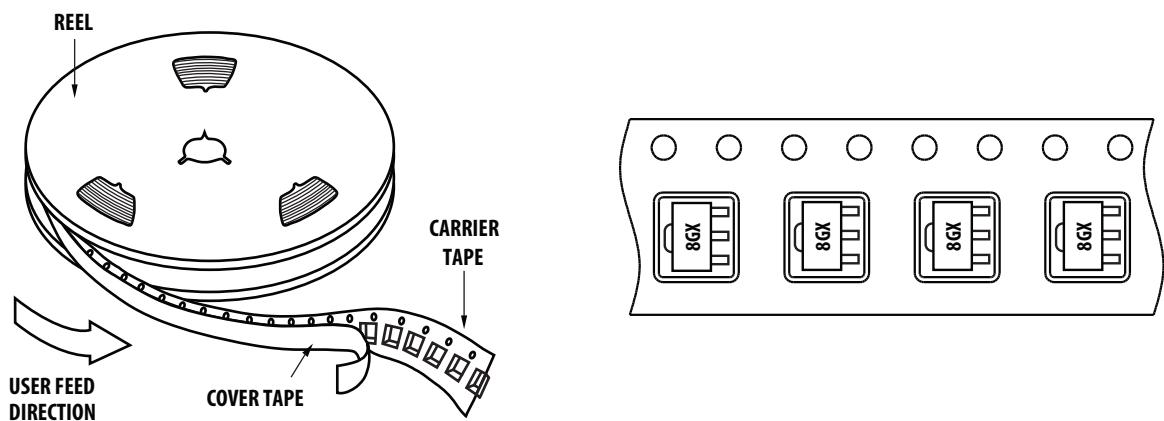
Part Number	No. of Devices	Container
MGA-30889-BLKG	100	7" Tape/Reel
MGA-30889-TR1G	3000	13" Tape/Reel

SOT89 Package Dimensions

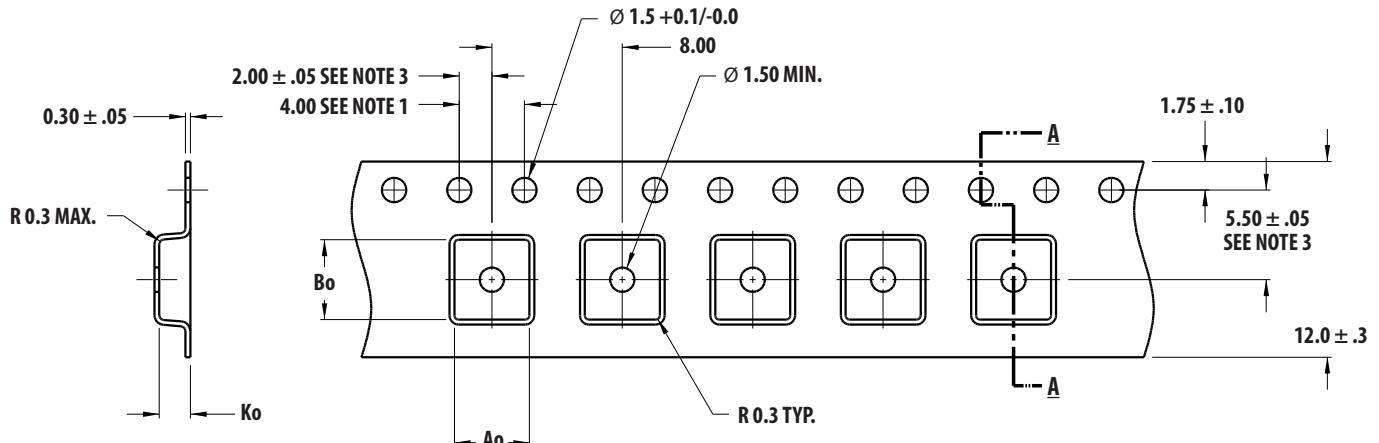


Symbols	Dimensions in mm			Dimensions in inches		
	Minimum	Nominal	Maximum	Minimum	Nominal	Maximum
A	1.40	1.50	1.60	0.055	0.059	0.063
L	0.89	1.04	1.20	0.0350	0.041	0.047
b	0.36	0.42	0.48	0.014	0.016	0.018
b1	0.41	0.47	0.53	0.016	0.018	0.030
C	0.38	0.40	0.43	0.014	0.015	0.017
D	4.40	4.50	4.60	0.173	0.177	0.181
D1	1.40	1.60	1.75	0.055	0.062	0.069
D2	1.45	1.65	1.80	0.055	0.062	0.069
E	3.94	-	4.25	0.155	-	0.167
E1	2.40	2.50	2.60	0.094	0.098	0.102
e1	2.90	3.00	3.10	0.114	0.118	0.122
S	0.65	0.75	0.85	0.026	0.030	0.034
e	1.40	1.50	1.60	0.054	0.059	0.063

Device Orientation



Tape Dimensions



SECTION A - A

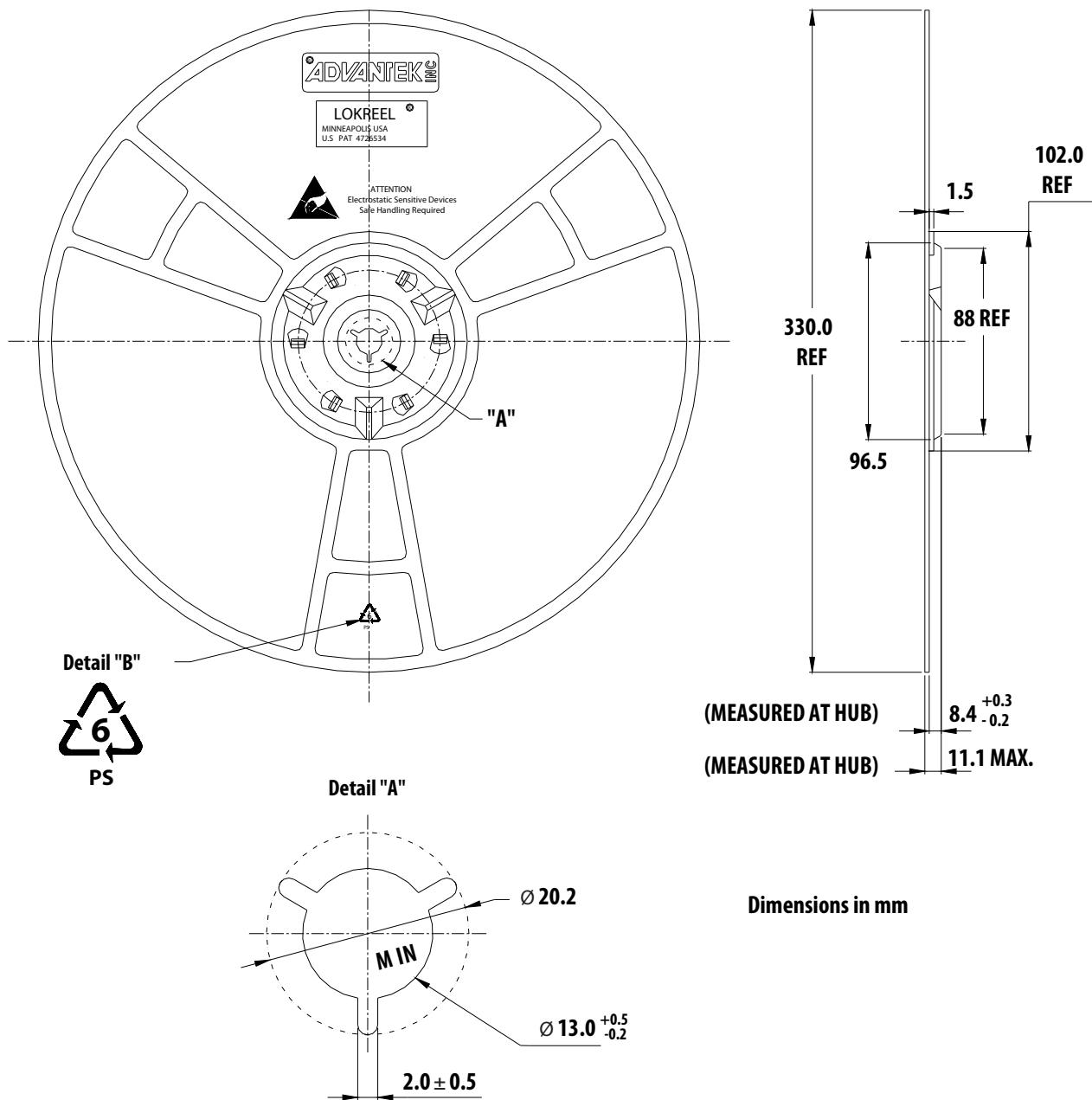
$Ao = 4.60$
 $Bo = 4.90$
 $Ko = 1.90$

DIMENSIONS IN MM

NOTES:

1. 10 SPROCKET HOLE PITCH CUMULATIVE TOLERANCE ± 0.2
2. CAMBER IN COMPLIANCE WITH EIA 481
3. POCKET POSITION RELATIVE TO SPROCKET HOLE MEASURED AS TRUE POSITION OF POCKET, NOT POCKET HOLE

Reel Dimensions – 13" Reel



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